BaSyTec CTS

Battery Test System

1-6V or +/-6V

up to 5A (20A)

up to 200nA current accuracy

optional reference electrode input

The BaSyTec CTS is the reference when testing small cells from material probes in 3 electrode arrangement up to mid size cells up to 20A.

Of course also our CTS is controlled by our **powerful and comfortable BaSyTest Software**.

The 4 automatic dynamic switching current ranges (switching without interruption) (plus paralleling) result in a relative accuracy of at least 0.33% within the whole range from **60µA to 20A**.



BaSyTec Battery Test Systems

Our Systems are modular, flexible and user friendly

BaSyTec CTS

Battery Test System

Technical data:

	CTS Standard	CTS LAB	CTS LAB XL	
Channels per unit (max.)	32		20	
Voltage range	0-6V	+/-6V		
4-wire measurement	yes			
Min. discharge voltage	200mV or 0.2Ω*current (whichever is greater)	-6V		
Current ranges (charge + discharge)	5A /300mA/ 15mA/1mA	3A /250mA/ 15mA/ 1mA	5A /300mA/ 15mA/1mA	
Current accuracy	1mA/50μA/ 2.5μA/0.2μA	0.5mA/50μA/ 2.5μA/0.2μA	1mA/50μA/ 2.5μA/0.2μA	
Voltage accuracy	1mV			
Resolution	16Bit / 1us			
Parallel operation	Yes, up to 4 channels			
Add. inputs per channel	NTC temperature (for Epcos B57861S0502) optional reference voltage (+/-6V, 1mV accuracy, leackage < 50nA, 200ms samplerate)			
Digital-IO	Optional, TTL-like, 3 per channel, not isolated			
Sampling rate Output change rate	Peak 0.5ms but not more than 1kHz continually per Min. 10ms system			
Current rise time	< 50µs			
3-Electrode configurations	limited	yes	yes	
Control mode	Current, voltage, power, resistance and combinations			
Other methods	Cyclic voltammetry, GITT,			
Software	BaSyTest			
Interface	Ethernet			
Battery connectors	D-SUB 9-pin Holders for cylindric cells available			
Size per unit (max.)	19" system 6HE units, 450*280*550mm			
Weight per unit (max.)	28kg (32 channels)			
Noise	< 55dB(A)			
Input power / voltage range	< 1700W / 110-264VAC / 47-63Hz			
Max. input current per unit	< 16/	< 16A @ 110V, < 8A @ 220V		

02/2023

BaSyTec Battery Test Systems